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|-----------------------------------|---------------------------------------|--|---|-------------|
| Notice of References Cited | Application/Control No. 10/782,787 | | Applicant(s)/Patent Under Reexamination KANO ET AL. | |
| | Examiner Kevin Verbrugge | | Art Unit 2188 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------|----------------|
| X | A | US-5,897,661 A | 04-1999 | Baranovsky et al. | 711/170 |
| X | B | US-6,728,831 B1 | 04-2004 | Bridge, William | 711/112 |
| X | C | US-6,266,740 B1 | 07-2001 | Don et al. | 711/114 |
| X | D | US-6,718,436 B2 | 04-2004 | Kim et al. | 711/114 |
| X | E | US-2002/0073297 A1 | 06-2002 | Mizuno et al. | 711/202 |
| X | F | US-2003/0236945 A1 | 12-2003 | Nahum, Nelson | 711/114 |
| X | G | US-6,058,489 A | 05-2000 | Schultz et al. | 714/7 |
| X | H | US-6,366,988 B1 | 04-2002 | Skiba et al. | 711/165 |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
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| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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